

SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS PRODUCT SPECIFICATION 規格書

CUSTOMER: (客戶):

DATE: (日期):2015-12-12

CATEGORY (品名)	: ALUMINUM ELECTROLYTIC CAPACITORS
DESCRIPTION (型号)	: GT 25V330μF(φ8X12)
VERSION (版本)	: 01
Customer P/N	:
SUPPLIER	:

SUPPI	JER	CUST	OMER
PREPARED (拟定)	CHECKED (审核)	APPROVAL (批准)	SIGNATURE (签名)
郭梦玉	王国华		

ELECTROLYTIC CAPACITOR SPECIFICATION GT SERIES

		SPECIFICAT	ALTERNATION HISTORY RECORDS				
Rev.	Date	GT SERIE Mark	ES Page	Contents	Purpose	Drafter	Approver
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	ELECTROLYTICMAN YUE ELECTRONICSCAPACITORCOMPANY LIMITEDSPECIFICATIONGT SERIES					CAPACITOR SPECIFICATION				S	AMX	ON		
Tab	le 1 Product Dimen	sions a	und Ch	aracteristic	: S						Unit: m	ım		
	Safety vent for $\geq \Phi$ 6.3		5 min	$d\pm 0.03$	5 -		F±0.5	β¢ *lfitis	20:α=1.5; L2 2D<20:β=0.5 flat rubber, urface.	; ΦD≥20	: β=1.0	from th	ie flat r	ubber
N o.	SAMXON Part No.	WV (Vdc)	Cap. (µF)	Cap. tolerance	Temp. range(℃)	tanδ (120Hz, 20℃)	Leakage Current (µA,2min)	Max Ripple Current at 105°C 100KHz (mA_rms)	Impedance at 20°C 100kHz (Ωmax)	Load lifeti me (Hrs)	Dir D×L	mension (mm) F	n ¢d	Sleev
1	EGT337M1EF12RR**P	25	330	-20%~+20%	-40~105	0.14	82	640	0.130	7000	8X12	3.5	0.5	PET
0.	Part No.	(Vdc)	(µF)		range(℃)	(120Hz, 20℃)	Current (µA,2min)	Current at 105°C 100KHz (mA rms)	at 20°C 100kHz (Ωmax)	lifeti me (Hrs)	D×L	(mm) F	фd	

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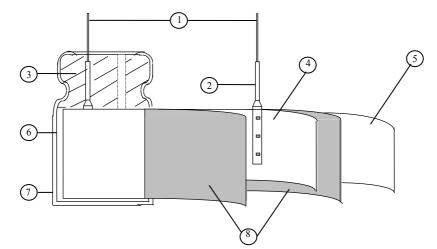
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EXC 0.33 334 ± 15 L 8 0K 23 F 20mm Pitch TT EXM 0.47 474 ± 15 L 12.5 18 12.5 1 20mm Pitch TT EXF 1 105 ± 20 M 220 10 14 4 4 36mm Pitch TV EXF 1 105 ± 20 M 220 10 14 4 4 36mm Pitch TV 36mm Pitch TV 50mm Pitch TC 10 106 20 10 165 7 50mm Pitch TC Load Cut & Form Exer 10 106 20 C 73 110 36 9 CE=Type CE 10 106 20 C 73 110 36 6 116 10 10 20 77 110 10 10 10 10 10 10 10 10 10 10		EKS EGS	0.22	224	+10	к				C D	Ammo Tap	ng		
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			3300000	33M					260 270	28 2T				

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3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	РЕТ
8	Separator	Electrolyte paper

4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature	:15°C to 35°C
Relative humidity	: 45% to 85%
Air Pressure	: 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature	$: 20^{\circ}C \pm 2^{\circ}C$
Relative humidity	: 60% to 70%
Air Pressure	: 86kPa to 106kPa

Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

Version	01		Ρασρ	5
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WV (V.DC) 6.3 10 16 25	35 50 63	100
SV (V.DC) 8 13 20 32	44 63 79	125
	50 400 420 450 .00 450 470 500	
<pre><condition> Measuring Frequency : 120Hz±12Hz</condition></pre>		
Measuring Voltage : Not more than 0.5 Measuring Temperature : $20\pm 2^{\circ}C$	5Vrms	
<criteria> Shall be within the specified capacitance toler</criteria>	rance.	
<condition> Connecting the capacitor with a protective r minutes, and then, measure Leakage Current. <criteria> Refer to Table 1</criteria></condition>	resistor $(1k \Omega \pm 10 \Omega)$ in serie	es for
<condition> See 4.2, Norm Capacitance, for measuring fre <criteria> Refer to Table 1</criteria></condition>	equency, voltage and temperatur	e.
 <condition> Tensile Strength of Terminals Fixed the capacitor, applied force to the tenseconds. Bending Strength of Terminals. Fixed the capacitor, applied force to bent the 90° within 2~3 seconds, and then bent it for seconds. </condition> 	e terminal (1~4 mm from the rub r 90° to its original position with	ber) f
Diameter of lead wire (kgf)	(kgf)	
	, , ,	
Fixed the capacitor, applied force to bent the 90° within 2~3 seconds, and then bent it for seconds.	r 90° to its original posi ce N Bending for (kgf) .) 2.5 (0.25) 5 (0.51)	tion wit ce N)

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		STI	EP Testi		rature(°C)			Time		
		1		20 ± 2				ch thermal e	1	
		2		-40(-25)	± 3	Time	to reac	ch thermal e	quilibriu	m
		3		20 ± 2	2	Time	to reac	ch thermal e	quilibriu	m
		4		105 ± 2 Time to reach thermal equilibrium		m				
		5	20 ± 2 Time to reach thermal equilibrium		m					
		<criteria></criteria>	>	all be within the limit of Item 4.4The leakage current measured shall						
						4.4The lo	eakage	current mea	asured sh	nall not
	Tommorotumo		8 times of i	-						
	Temperature characteristi				hin the lin	nit of Iter	n 4.4T	he leakage	current s	shall no
4.6	cs		the specifie			1 11 /	1	a 1	C (1 C 11	
		table.		mpedance	(z) ratio s	shall not	exceed	the value o	t the foll	owing
		Working V		6.3	10	16	25	35	50	63
		Z-25°C/2	Z+20℃	5	4	3	2	2	2	2
		Z-40°C/2	Z+20°C	10	8	6	4	3	3	3
		Working V	oltage (V)	100	160~22) 250~	350	400~420	450	
		Z-25°C/Z	- · · ·	2	3	4		6	15	_
		Z-40°C/2	Z+20°C							
			ance value > 1000 μ F, Add 0.5 per another 1000 μ F for Z-25/Z+20							
		-			Add 1.0) per anot	her 10	00 µ F for Z		
		For capacit Capacitance <conditio< td=""><td>e, tan δ , and</td><td></td><td>Add 1.0</td><td>) per anot</td><td>her 10</td><td>00 µ F for Z</td><td></td><td></td></conditio<>	e, tan δ , and		Add 1.0) per anot	her 10	00 µ F for Z		
		Capacitance <conditio< td=""><td>e, tan δ, and n></td><td>d impedar</td><td>Add 1.0</td><td>) per anot e measur</td><td>her 10 ed at 1</td><td>00 µ F for Z</td><td>Z-40℃/Z</td><td>+20°C</td></conditio<>	e, tan δ , and n >	d impedar	Add 1.0) per anot e measur	her 10 ed at 1	00 µ F for Z	Z-40℃/Z	+20°C
		Capacitance Conditio According 105°C ±2	e, tan ^δ , and n> to IEC6038 with DC bi	d impedar 34-4No.4. as voltage	Add 1.0 nce shall b 13 method e plus the r) per anot e measur ls, The ca rated ripp	her 10 ed at 1 pacito le curr	00 µ F for Z 20Hz. r is stored at ent for Tab	L-40°C/Z t a tempe le 1. (Th	+20°C erature he sum
		Capacitance Conditio According 105°C ±2 DC and ri	e, tan δ , and n> to IEC6038 with DC bi pple peak	d impedar 34-4No.4. as voltage voltage sł	Add 1.0 nce shall b 13 method e plus the mall not ex) per anot e measur ls, The ca rated ripp kceed the	her 10 ed at 1 pacito le curr e rated	00 µ F for Z 20Hz. r is stored at ent for Tab working v	t a tempe le 1. (Th oltage)	+20°C erature he sum Γhen t
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	Load	Capacitance <conditio According 105°C ±2 DC and ri product show result show</conditio 	e, tan δ, and n> to IEC6038 with DC bi pple peak ould be test ild meet the	d impedar 34-4No.4. as voltage voltage sh ed after 16	Add 1.0 nce shall b 13 method e plus the r nall not e: 6 hours red) per anot e measur ls, The ca rated ripp kceed the	her 10 ed at 1 pacito le curr e rated	00 µ F for Z 20Hz. r is stored at ent for Tab working v	t a tempe le 1. (Th oltage)	+20℃ erature ae sum Γhen t
4.7	life	Capacitance <conditio According 105°C ±2 DC and ri product sho result shou <criteria< td=""><td>e, tan δ, and n> to IEC6038 with DC bi pple peak ould be test ild meet the ></td><td>d impedar 34-4No.4. as voltage voltage sh ed after 16 following</td><td>Add 1.0 nce shall b 13 method e plus the n nall not ex 6 hours red g table:</td><td>) per anot e measur ls, The ca rated ripp kceed the covering</td><td>her 10 ed at 1 pacito le curr rated time at</td><td>00 µ F for Z 20Hz. r is stored at ent for Tab working v atmospheri</td><td>t a tempe le 1. (Th oltage)</td><td>+20℃ erature ae sum Γhen t</td></criteria<></conditio 	e, tan δ , and n > to IEC6038 with DC bi pple peak ould be test ild meet the >	d impedar 34-4No.4. as voltage voltage sh ed after 16 following	Add 1.0 nce shall b 13 method e plus the n nall not ex 6 hours red g table:) per anot e measur ls, The ca rated ripp kceed the covering	her 10 ed at 1 pacito le curr rated time at	00 µ F for Z 20Hz. r is stored at ent for Tab working v atmospheri	t a tempe le 1. (Th oltage)	+20℃ erature ae sum Γhen t
4.7		Capacitance <conditio According 105°C ±2 DC and ri product shou <criteria The charac</criteria </conditio 	e, tan δ , and m> to IEC6038 with DC bi pple peak ould be testo ild meet the > cteristic sha	d impedar 34-4No.4. as voltage voltage sh ed after 16 following <u>ll meet th</u>	Add 1.0 nce shall b 13 method e plus the r hall not ex 6 hours red g table: e followin) per anot e measur ls, The ca rated ripp kceed the covering g require	her 10 ed at 1 pacito le curr e rated time at ments.	00 µ F for Z 20Hz. r is stored at ent for Tab working v atmospheri	t a tempe le 1. (Th oltage)	+20℃ erature ae sum Γhen t
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		<criteria></criteria>	
		The characteristic shall meet the	
		Leakage current	Value in 4.3 shall be satisfied
1.0	Shelf	Capacitance Change	Within $\pm 20\%$ of initial value.
4.8	life	tan δ	Not more than 200% of the specified value.
	test	Appearance	There shall be no leakage of electrolyte.
			ored more than 1 year, the leakage current may
			hrough about 1 k Ω resistor, if necessary.
		<condition></condition>	
			capacitor connected with a $(100 \pm 50)/C_R (k\Omega)$ resistor
			d to 1000 cycles, each consisting of charge of 30 ± 5 s
		followed discharge of 5 min 30	
		The test temperature shall be	
		C _R :Nominal Capacitance (µ I	F)
	Surge	<criteria></criteria>	Not more than the aposition value
4.9	test		Not more than the specified value.
		Capacitance Change	Within $\pm 15\%$ of initial value.
		tan δ	Not more than the specified value.
		Appearance	There shall be no leakage of electrolyte.
		Attention:	
			at abnormal situation only. It is not applicable to such
		over voltage as often applied.	
4.10	Vibration test	perpendicular directions. Vibration frequency rang Peak to peak amplitude Sweep rate Mounting method: The capacitor with diameter gree in place with a bracket. 4mm or less	ge : 10Hz ~ 55Hz : 1.5mm : 10Hz ~ 55Hz ~ 10Hz in about 1 minute eater than 12.5mm or longer than 25mm must be fixed Within 30°
		Appearance of	To be soldered ms shall be tested: o intermittent contacts, open or short circuiting. o damage of tab terminals or electrodes. o mechanical damage in terminal. No leakage electrolyte or swelling of the case. e markings shall be legible.

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		<condition> The capacitor shall be tested up</condition>	nder the following	conditions:	
		Soldering temperature	: 245±3°C		
		Dipping depth	: 2mm	,	
4.11	Solderability test	Dipping speed	: 25±2.5mm : 3±0.5s	n/s	
	test	Dipping time < Criteria >	. 5±0.58		
			A minimur	n of 95% of the surface	being
		Coating quality	immersed		
		<condition></condition>	11 h . :		5°Cf==10
		Terminals of the capacitor shall			
		1 seconds or $400 \pm 10^{\circ}$ C for 3^{+1}_{-0}			
	D	Then the capacitor shall be left for 1~2 hours before measuren		temperature and norma	l humidity
4.12	Resistance to solder heat	< <u>Criteria></u>	iciit.		
7.12	test	Leakage current	Not more than t	he specified value.	
		Capacitance Change	Within $\pm 10\%$ c	of initial value.	
		tan δ	Not more than t	he specified value.	
		Appearance	There shall be n	o leakage of electrolyte	e.
		<condition></condition>			
		Temperature Cycle:According			shall be
		placed in an oven, the conditio	-	Time	
		Temper (1)+20℃	lature	≤ 3 Minutes	
		(1)+20 C (2)Rated low temperature	$(40^{\circ}C)(25^{\circ}C)$	30 ± 2 Minutes	
	Change of			30 ± 2 Minutes 30 ± 2 Minutes	
4.13	temperature test	(3)Rated high temperature (1) to (2)=1 cucle, total 5		30 ± 2 Willines	
	test	(1) to (3)=1 cycle, total 5 (Criteria >	cycle		
		The characteristic shall meet th	e following require	ement	
			Not more than the s]
		tan δ	Not more than the s	specified value.	
		Appearance	There shall be no le	eakage of electrolyte.]
		<condition></condition> Humidity Test:			
		According to IEC60384-4No.4	12 methods capa	citor shall be exposed f	for 500 ± 8
		hours in an atmosphere of 90~	· 1	-	
		meet the following requirement		,	U
		<criteria></criteria>			I
4.14	Damp heat		more than the spe		
	test	1 0	$\frac{1}{20\%}$ of initiation $\frac{1}{20\%}$	al value. of the specified value.	
			re shall be no leak	•	
					l

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4.15	Vent test	<condition> The following test only apply to those products with vent products at diameter $\ge \emptyset 6.3$ with vent. D.C. test The capacitor is connected with its polarity reversed to a DC power source. Then a current selected from below table is applied. <table 3=""> $\overline{\text{Diameter (mm) DC Current (A)}}$ 22.4 or less 1 $\overline{\text{Over } 22.4}$ 10 Criteria> The vent shall operate with no dangerous conditions such as flames or dispersion of pieces of the capacitor and/or case.</table></condition>
4.16	Maximum permissible (ripple current)	Condition> The maximum permissible ripple current is the maximum A.C current at 120Hz and can be applied at maximum operating temperature Table-1 The combined value of D.C voltage and the peak A.C voltage shall not exceed the rated voltage and shall not reverse voltage. Frequency Multipliers: <u>Coefficient</u> <u>Freq.</u> <u>120</u> <u>300</u> <u>1K</u> <u>100k</u> <u>100k</u>

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5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances			
	Cadmium and cadmium compounds			
Heavy metals	Lead and lead compounds			
	Mercury and mercury compounds			
	Hexavalent chromium compounds			
	Polychlorinated biphenyls (PCB)			
Chloinated	Polychlorinated naphthalenes (PCN)			
organic	Polychlorinated terphenyls (PCT)			
compounds	Short-chain chlorinated paraffins(SCCP)			
	Other chlorinated organic compounds			
	Polybrominated biphenyls (PBB)			
Brominated	Polybrominated diphenylethers(PBDE) (including			
organic	decabromodiphenyl ether[DecaBDE])			
compounds	Other brominated organic compounds			
Tributyltin comp	pounds(TBT)			
Triphenyltin con	npounds(TPT)			
Asbestos				
Specific azo con	npounds			
Formaldehyde				
Beryllium oxide				
Beryllium copp	ber			
Specific phthalat	tes (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)			
Hydrofluorocarb	oon (HFC), Perfluorocarbon (PFC)			
Perfluorooctane	sulfonates (PFOS)			
Specific Benzoti	riazole			

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Attachment: Application Guidelines

1.Circuit Design

(2)

- 1.1 Operating Temperature and Frequency
- Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.
- (1) Effects of operating temperature on electrical parameters
 a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
 b) At human temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
 - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
 - Effects of frequency on electrical parameters
 - a) At higher frequencies capacitance and impedance decrease while tanb increases.
 - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).
- 1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

(1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

- 1.4 Using Two or More Capacitors in Series or Parallel
- (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

1.5 Capacitor Mounting Considerations

(1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2)Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

(5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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(6) Wiring Near the Pressure Relief Vent Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite. (7) Circuit Board patterns Under the Capacitor Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short. (8) Screw Terminal Capacitor Mounting Do not orient the capacitor with the screw terminal side of the capacitor facing downwards. Tighten the terminal and mounting bracket screws within the torque range specified in the specification. 1.6 Electrical Isolation of the Capacitor Completely isolate the capacitor as follows. (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths. 1.7 The Product endurance should take the sample as the standard. 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling. 1.9 Capacitor Sleeve The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor. The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures. CAUTION! Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use. (1) Provide protection circuits and protection devices to allow safe failure modes. (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure. 2.Capacitor Handling Techniques 2.1 Considerations Before Using (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment. (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about $1k\Omega$. (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately $1k\Omega$. (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors. (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result. 2.2 Capacitor Insertion (1) Verify the correct capacitance and rated voltage of the capacitor. (2) Verify the correct polarity of the capacitor before inserting. (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals. (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor. For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection. 2.3 Manual Soldering (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less. (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal. (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads. (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve. 2.4 Flow Soldering (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result. (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.

- (3) Do not allow other parts or components to touch the capacitor during soldering.
- 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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- 2.6 Capacitor Handling after Solder
- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.
- 2.7 Circuit Board Cleaning

Acetone

- Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

- Alkali solvents : could attack and dissolve the aluminum case.
- Petroleum based solvents: deterioration of the rubber seal could result.
- Xylene : deterioration of the rubber seal could result.
 - : removal of the ink markings on the vinyl sleeve could result.
- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.
- 2.8 Mounting Adhesives and Coating Agents
 - When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

3. Precautions for using capacitors

- 3.1 Environmental Conditions
 - Capacitors should not be stored or used in the following environments.
- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures. If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.
- If electrolyte or gas is ingested by month, gargle with water.
 - If electrolyte of gas is ingested by month, gargie with water.

5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000 Ω , current limiting resistor for a time period of 30 minutes. If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.